Resolution in Super-Resolution

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Why do Super-Resolution?

Because

• we want/require higher resolution.

- ...we want pretty pictures
- ... referees ask for them
- ...bosses ask for them

Expected resolution

Expected resolution				
	XY	Z	volume (fl)	relative volume
Widefield	220	550	0.02662	1
SIM	110	270	0.003267	0.122727273
STED	40	550	0.00088	0.033057851
STORM	20	50	0.00002	0.000751315

Realistic Resolution

Realistic resolution				
	XY	Z	volume (fl)	relative volume
Widefield	220	550	0.02662	1
SIM	110	270	0.003267	0.122727273
STED	80	550	0.00352	0.132231405
STORM	50	100	0.00025	0.009391435

SIM Resolution

- NA and hence stripe width
- Stripe contrast
- Signal to noise

STED Resolution

- Depletion beam power
- Probably gSTED, complicated balance between power and gating
- Signal to noise

Localisation imaging Resolution

- Photons per localisation
- PSF size
- Labelling density
- Overlapping fitting or rejection.
- Signal to noise

Microtubules in Drosophila macrophages



SIM: maximum intensity projection of two 125 nm z-sections

Primary antibody anti α tubulin, secondary antibody coupled to Alexa Fluor 488

Measuring Resolution

- Line widths of sub resolution objects (eg Microtubules)
- Fall off in intensity with frequency in Fourier Transforms

Microtubule widths



Representative single microtubules with Gaussian fits

Fourier Transforms to Assess Resolution





Widefield

Deconvolved Widefield

Fourier Transforms to Assess Resolution





FFT of Widefield FTs of Microtubule images at equivalent scale

Radial Integrals of FTs



Fourier Transforms to Assess Resolution

FTs of Microtubule images at equivalent scale

Radial Integrals of FTs



Localisation precision by Fourier ring correlation



Going beyond the image resolution



Centriol, imaging

Line profiles from different proteins



Simulations of 2 Gaussian peaks



Simulated and experimental results



Results of 2-peak fits



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